



## General Description

The IPP05CN10LG use advanced SGT MOSFET technology to provide low  $R_{DS(ON)}$ , low gate charge, fast switching and excellent avalanche characteristics. This device is specially designed to get better ruggedness.

## General Features

$V_{DS} = 100V$   $I_D = 120A$

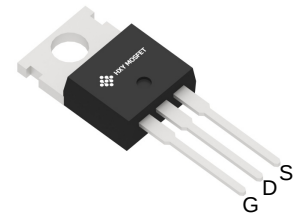
$R_{DS(ON)} < 5.0m\Omega$  @  $V_{GS}=10V$

## Applications

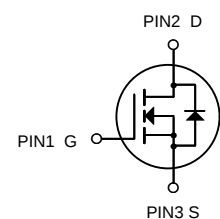
Consumer electronic power supply Motor control

Synchronous-rectification Isolated DC

Synchronous-rectification applications



TO-220C



N-Channel MOSFET

## Package Marking and Ordering Information

| Product ID  | Pack    | Brand      | Qty(PCS) |
|-------------|---------|------------|----------|
| IPP05CN10LG | TO-220C | HXY MOSFET | 50       |

## Absolute Maximum Ratings at $T_J=25^{\circ}C$ unless otherwise noted

| Parameter                                                 | Symbol          | Value      | Unit          |
|-----------------------------------------------------------|-----------------|------------|---------------|
| Drain source voltage                                      | $V_{DS}$        | 100        | V             |
| Gate source voltage                                       | $V_{GS}$        | $\pm 20$   | V             |
| Continuous drain current <sup>1)</sup> $T_C=25^{\circ}C$  | $I_D$           | 120        | A             |
| Continuous drain current <sup>1)</sup> $T_C=100^{\circ}C$ | $I_D$           | 81         | A             |
| Pulsed drain current <sup>2)</sup>                        | $I_{DM}$        | 512        | A             |
| Power dissipation <sup>4)</sup>                           | $P_D$           | 178        | W             |
| Single pulsed avalanche energy <sup>3)</sup>              | EAS             | 486        | mJ            |
| Operation and storage temperature                         | $T_{stg}, T_J$  | -55 to 150 | $^{\circ}C$   |
| Thermal resistance, junction-case                         | $R_{\theta JC}$ | 0.8        | $^{\circ}C/W$ |
| Thermal resistance, junction-ambient <sup>4)</sup>        | $R_{\theta JA}$ | 56         | $^{\circ}C/W$ |



### Electrical Characteristics (T<sub>J</sub> = 25°C, unless otherwise noted)

| Symbol                              | Parameter                                      | Conditions                                                                             | Min. | Typ. | Max. | Unit  |
|-------------------------------------|------------------------------------------------|----------------------------------------------------------------------------------------|------|------|------|-------|
| BV <sub>DSS</sub>                   | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V, I <sub>D</sub> =250uA                                             | 100  | ---  | ---  | V     |
| ΔBV <sub>DSS</sub> /ΔT <sub>J</sub> | BV <sub>DSS</sub> Temperature Coefficient      | Reference to 25°C, I <sub>D</sub> =1mA                                                 | ---  | ---  | ---  | V/°C  |
| R <sub>DS(ON)</sub>                 | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =10V, I <sub>D</sub> =20A                                              | ---  | 4.1  | 5.0  | mΩ    |
|                                     |                                                | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A                                             | ---  | ---  | ---  |       |
| V <sub>GS(th)</sub>                 | Gate Threshold Voltage                         | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA                               | 2.0  | 3.0  | 4.0  | V     |
| ΔV <sub>GS(th)</sub>                | V <sub>GS(th)</sub> Temperature Coefficient    |                                                                                        | ---  | ---  | ---  | mV/°C |
| I <sub>DSS</sub>                    | Drain-Source Leakage Current                   | V <sub>DS</sub> =80V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                        | ---  | ---  | 1    | uA    |
|                                     |                                                | V <sub>DS</sub> =80V, V <sub>GS</sub> =0V, T <sub>J</sub> =100°C                       | ---  | ---  | 100  |       |
| I <sub>GSS</sub>                    | Gate-Source Leakage Current                    | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                                             | ---  | ---  | ±100 | nA    |
| g <sub>fs</sub>                     | Forward Transconductance                       | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                               | ---  | 35   | ---  | S     |
| R <sub>g</sub>                      | Gate Resistance                                | V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz                                       | ---  | 1.6  | ---  | Ω     |
| Q <sub>g</sub>                      | Total Gate Charge                              | V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A                        | ---  | 69   | ---  | nC    |
| Q <sub>gs</sub>                     | Gate-Source Charge                             |                                                                                        | ---  | 24   | ---  |       |
| Q <sub>gd</sub>                     | Gate-Drain Charge                              |                                                                                        | ---  | 18.5 | ---  |       |
| T <sub>d(on)</sub>                  | Turn-On Delay Time                             | V <sub>GS</sub> =10V, V <sub>DD</sub> =50V,<br>R <sub>G</sub> =3Ω, I <sub>D</sub> =20A | ---  | 18.0 | ---  | ns    |
| T <sub>r</sub>                      | Rise Time                                      |                                                                                        | ---  | 23   | ---  |       |
| T <sub>d(off)</sub>                 | Turn-Off Delay Time                            |                                                                                        | ---  | 37   | ---  |       |
| T <sub>f</sub>                      | Fall Time                                      |                                                                                        | ---  | 15.7 | ---  |       |
| C <sub>iss</sub>                    | Input Capacitance                              | V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz                                      | ---  | 4102 | ---  | pF    |
| C <sub>oss</sub>                    | Output Capacitance                             |                                                                                        | ---  | 592  | ---  |       |
| C <sub>rss</sub>                    | Reverse Transfer Capacitance                   |                                                                                        | ---  | 19.8 | ---  |       |

### Diode Characteristics

| Symbol          | Parameter                                | Conditions                                                    | Min. | Typ. | Max. | Unit |
|-----------------|------------------------------------------|---------------------------------------------------------------|------|------|------|------|
| I <sub>S</sub>  | Continuous Source Current <sup>1,5</sup> | V <sub>G</sub> =V <sub>D</sub> =0V, Force Current             | ---  | ---  | 120  | A    |
| V <sub>SD</sub> | Diode Forward Voltage <sup>2</sup>       | V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C | ---  | ---  | 1.2  | V    |

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%

3. The EAS data shows Max. rating. The test condition is T<sub>J</sub> = 25°C, L = 3.0mH, I<sub>AS</sub> = 18A, V<sub>GS</sub> = 10V, V<sub>DD</sub> = 50V; 100% test at L = 0.1mH, I<sub>AS</sub> = 67A.

4. The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.



## Typical Characteristics

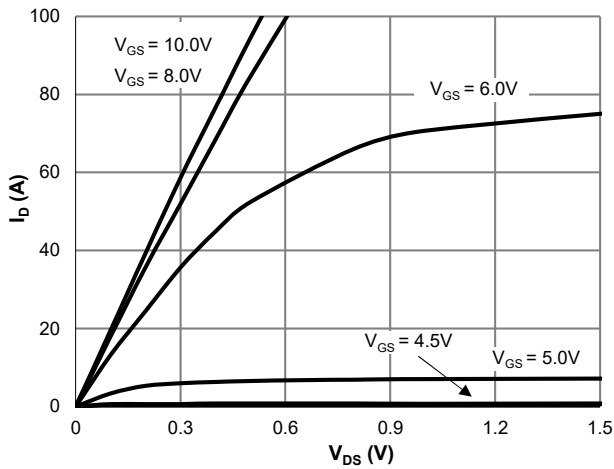


Figure 1: Saturation Characteristics

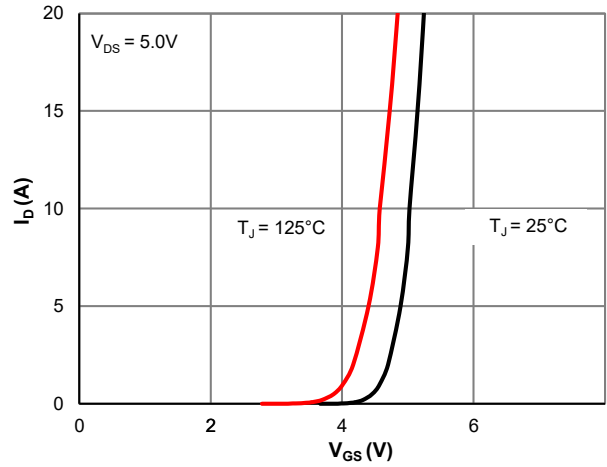


Figure 2: Transfer Characteristics

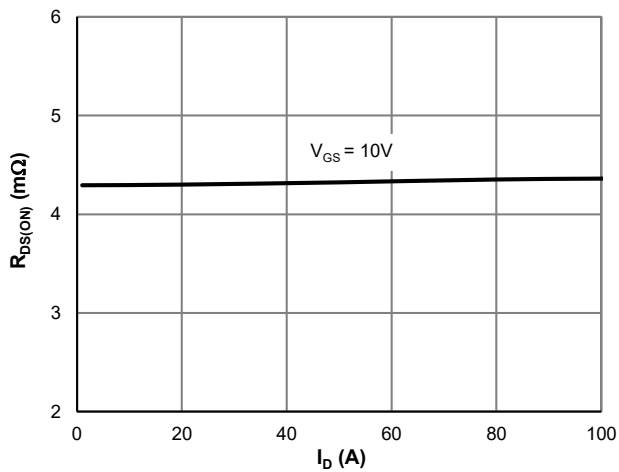


Figure 3:  $R_{DS(ON)}$  vs. Drain Current

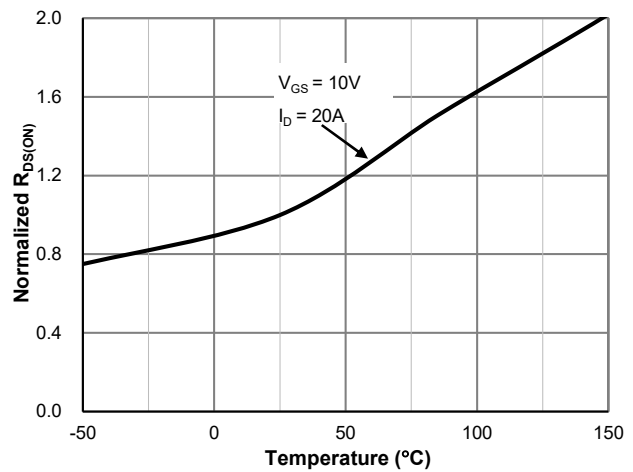


Figure 4:  $R_{DS(ON)}$  vs. Junction Temperature

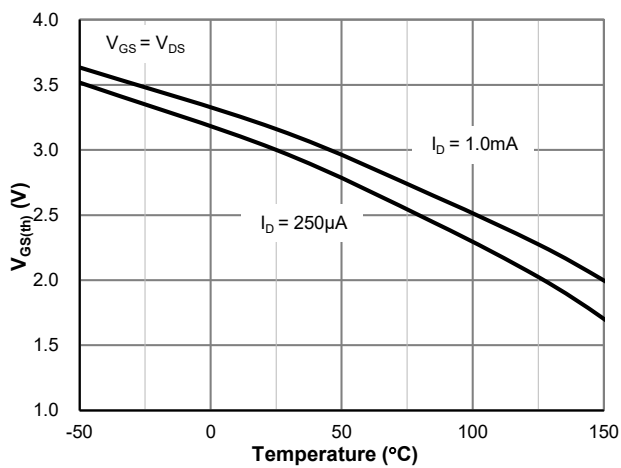


Figure 5:  $V_{GS(th)}$  vs. Junction Temperature

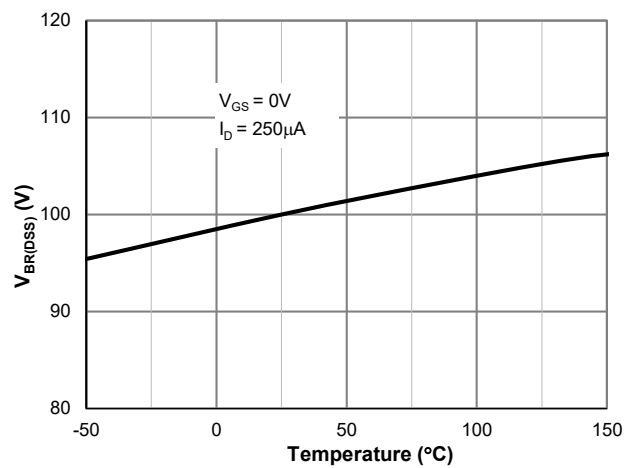


Figure 6:  $V_{BR(DSS)}$  vs. Junction Temperature

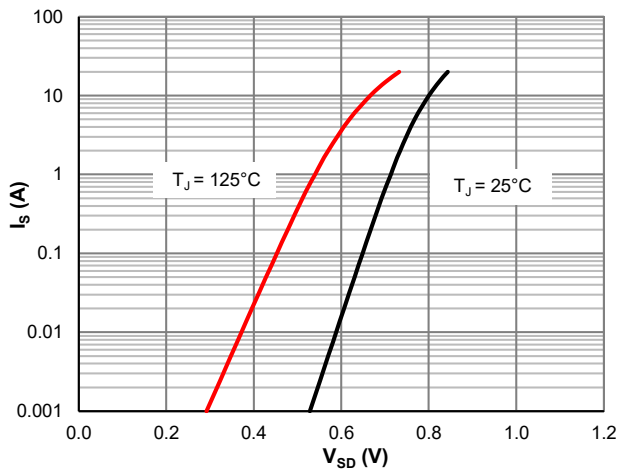


Figure 7: Body-Diode Characteristics

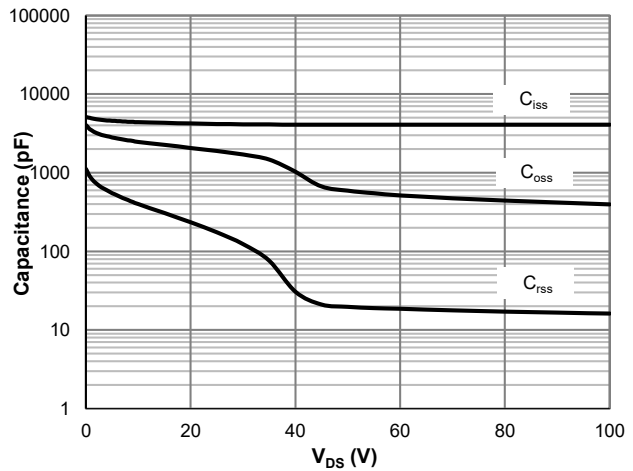


Figure 8: Capacitance Characteristics

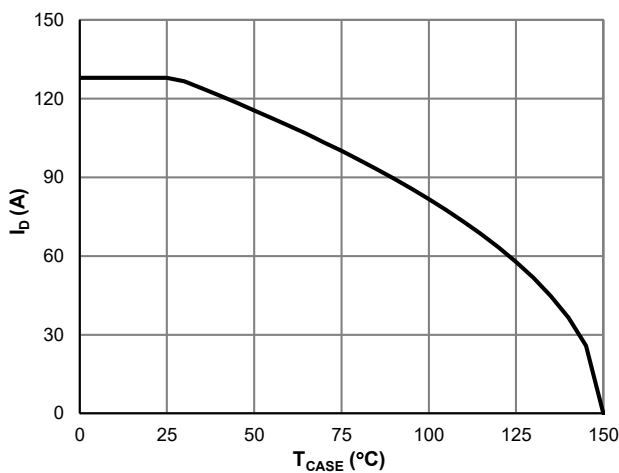


Figure 9: Current De-rating

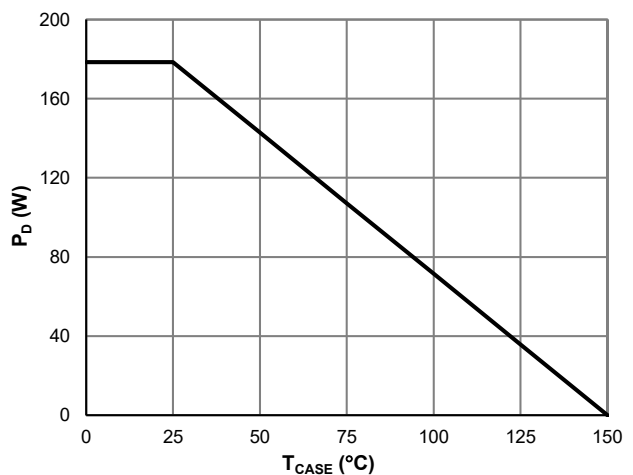


Figure 10: Power De-rating

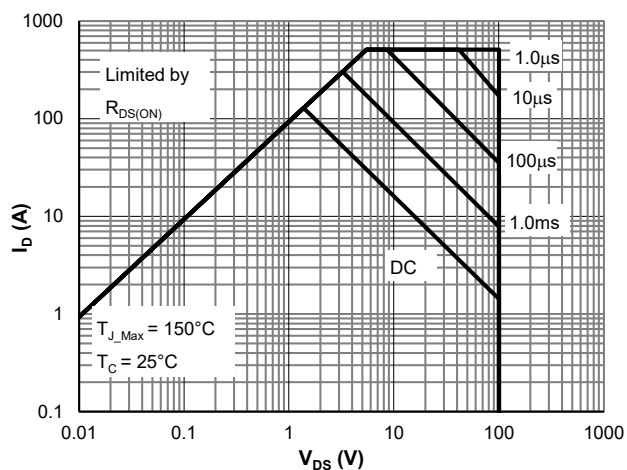


Figure 11: Maximum Safe Operating Area

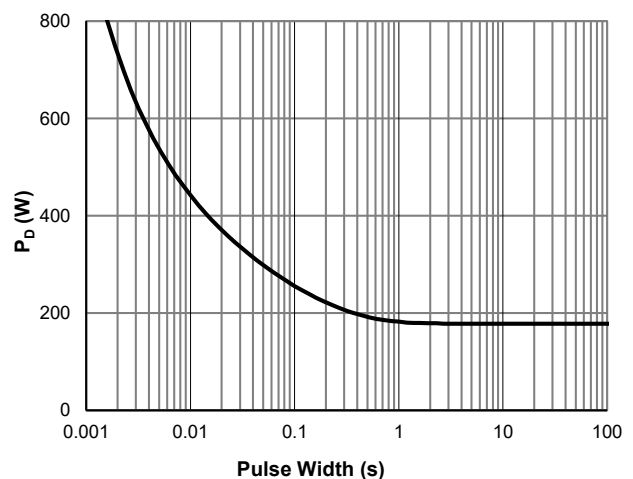


Figure 12: Single Pulse Power Rating, Junction-to-Case

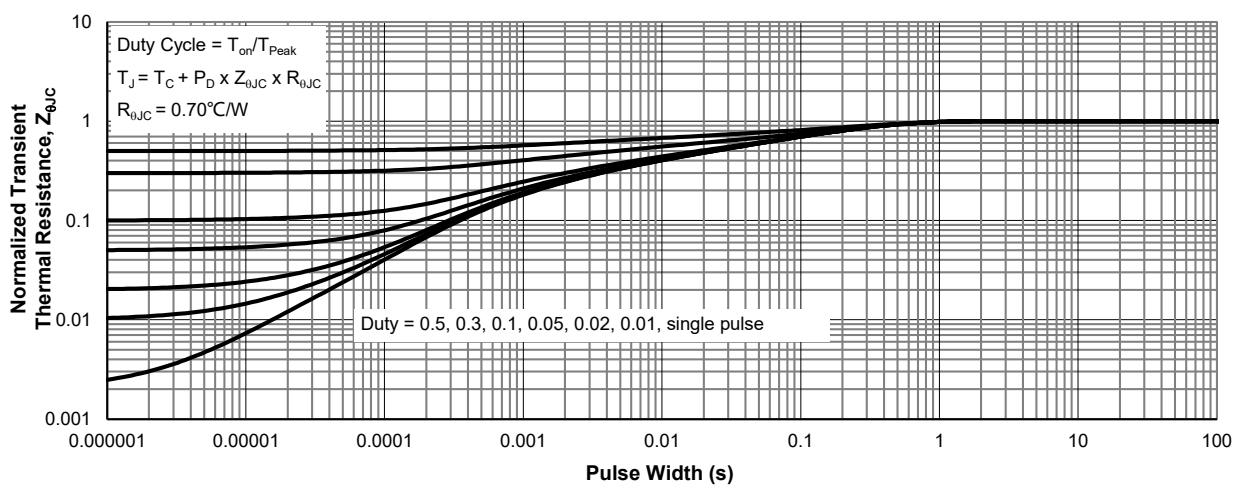
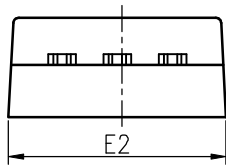
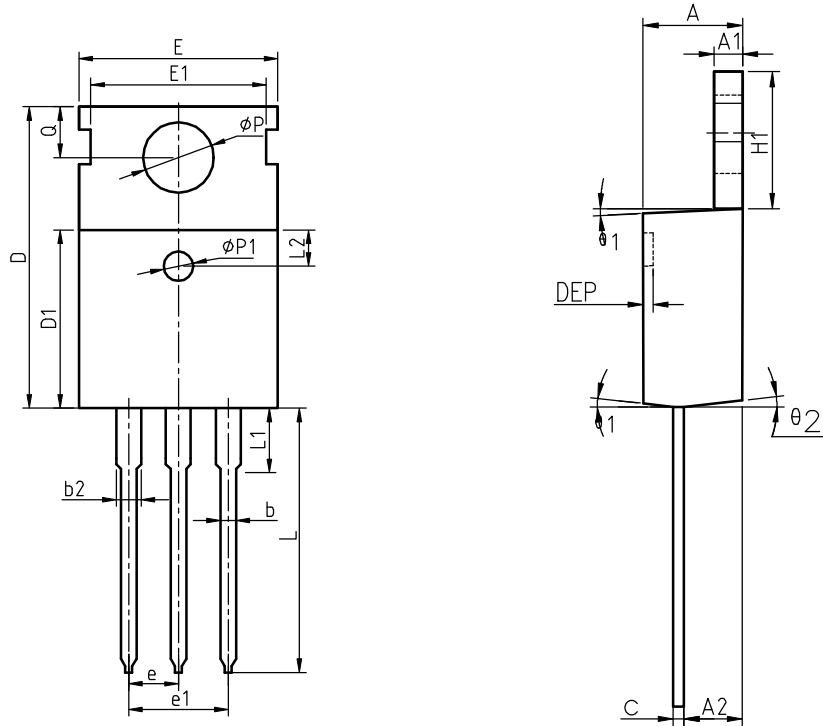


Figure 13: Normalized Maximum Transient Thermal Impedance



## Package Information

### TO-220C



COMMON DIMENSIONS

| SYMBOL | MIN      | NOM   | MAX   | MIN       | NOM   | MAX   |
|--------|----------|-------|-------|-----------|-------|-------|
| A      | 4.40     | 4.57  | 4.70  | 0.173     | 0.180 | 0.185 |
| A1     | 1.27     | 1.30  | 1.33  | 0.050     | 0.051 | 0.052 |
| A2     | 2.35     | 2.40  | 2.50  | 0.093     | 0.094 | 0.098 |
| b      | 0.77     | 0.80  | 0.90  | 0.030     | 0.031 | 0.035 |
| b2     | 1.17     | 1.27  | 1.36  | 0.046     | 0.050 | 0.054 |
| c      | 0.48     | 0.50  | 0.56  | 0.019     | 0.020 | 0.022 |
| D      | 15.40    | 15.60 | 15.80 | 0.606     | 0.614 | 0.622 |
| D1     | 9.00     | 9.10  | 9.20  | 0.354     | 0.358 | 0.362 |
| DEP    | 0.05     | 0.10  | 0.20  | 0.002     | 0.004 | 0.008 |
| E      | 9.80     | 10.00 | 10.20 | 0.386     | 0.394 | 0.402 |
| E1     | -        | 8.70  | -     | -         | 0.343 | -     |
| E2     | 9.80     | 10.00 | 10.20 | 0.386     | 0.394 | 0.402 |
| e      | 2.54 BSC |       |       | 0.100 BSC |       |       |
| e1     | 5.08 BSC |       |       | 0.200 BSC |       |       |
| H1     | 6.40     | 6.50  | 6.60  | 0.252     | 0.256 | 0.260 |
| L      | 12.75    | 13.50 | 13.65 | 0.502     | 0.531 | 0.537 |
| L1     | -        | 3.10  | 3.30  | -         | 0.122 | 0.130 |
| L2     | 2.50 REF |       |       | 0.098 REF |       |       |
| P      | 3.50     | 3.60  | 3.63  | 0.138     | 0.142 | 0.143 |
| P1     | 3.50     | 3.60  | 3.63  | 0.138     | 0.142 | 0.143 |
| Q      | 2.73     | 2.80  | 2.87  | 0.107     | 0.110 | 0.113 |
| θ 1    | 5°       | 7°    | 9°    | 5°        | 7°    | 9°    |
| θ 2    | 1°       | 3°    | 5°    | 1°        | 3°    | 5°    |
| θ 3    | 1°       | 3°    | 5°    | 1°        | 3°    | 5°    |



### **Attention**

- Any and all HUA XUAN YANG ELECTRONICS products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your HUA XUAN YANG ELECTRONICS representative nearest you before using any HUA XUAN YANG ELECTRONICS products described or contained herein in such applications.
- HUA XUAN YANG ELECTRONICS assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein.
- Specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- HUA XUAN YANG ELECTRONICS CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all HUA XUAN YANG ELECTRONICS products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of HUA XUAN YANG ELECTRONICS CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. HUA XUAN YANG ELECTRONICS believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the HUA XUAN YANG ELECTRONICS product that you intend to use.